This ATM briefly describes modifications to system grounding philosophy from those applied on previous flights and provides system, component, and experiment grounding details.

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This ATM is written to document the ALSEP Array E grounding philosophy which has been modified from that employed in previous ALSEP systems. The grounding philosophy employed in flights A thru D is documented in ATM-411, 484 and 530.

Figures 1 thru 11 provide the details of the Array E component, central station and experiment grounding arrangements. The most significant changes in grounding philosophy from that of previous systems involves the use of the central station thermal plate as a ground plane. Previous systems employed a single point ground located in the PDU. In Array E the ground plane approach, which essentially enlarges the magnitude of the single point ground, is used to minimize inductance of paths between components. Inter-component inductance must be minimized in Array E because low power TTL logic, capable of faster switching rates than previous employed logic, is used extensively in the redesigned command decoder, data processor and PCU/PDU. Reducing inductance thus reduces L(di/dt) noise generated by logic switching coupled from circuit to circuit in the grounds.

Inductive paths in the central station are minimized by employing ground planes on component PC boards and by using the component mounting structure and base plate as an electrical signal return path. The thermal plate therefore provides the remaining portion of the signal return path. This concept minimizes inductance by employing the largest physical structures as a conducting ground path. To successfully implement this concept the component mounting structure, base and the thermal plate surface must be designed to provide good electrical continuity and a low impedance path at high frequencies. A design goal of less than 20 millivolts IXC or IXL drop and less than 20 milliohm resistance between two signal points has been established. The thermal plate and new components will employ gold mounting interfaces to optimize electrical continuity between mechanical interfaces. Thermal grease will not be employed if it is detrimental to electrical characteristics. The entire thermal plate will be gold plated to provide a low impedance path between components.

The thermal plate ground plane provides three means for completing ground connections.

a. Component mechanical mounting interface.
b. Terminal board mounting interface.
c. Two ground studs.
New component designs will employ method (a) but will carry a "safety" ground wire thru the component connector for test purposes. Previously designed components have been designed to operate on an anodized thermal plate. Their grounds will therefore be connected thru the central station harness to the thermal plate ground studs (method c). The RTG PCU/PDU and experiment grounds will use method b) to complete ground connections to the thermal plate ground plane. The use of multiple grounding techniques on the thermal plate does not violate the single point ground philosophy. This is possible because the impedance of signal return paths will be maintained below a level which can cause significant noise.

Figures 1 thru 9 depict the component grounding arrangements. The following comments apply:

a. Capacitors are depicted in signal lines to show DC isolation.

b. Internal dashed lines indicate component chassis which may be isolated from mounting surface chassis.

c. A chassis ground symbol depicts the conductive component/experiment mounting surface.

d. To minimize capacitive pickup the LEAM experiment may not use a separate chassis ground. The grounding arrangement employed will be dependent on development testing.

System grounding arrangements are depicted in Figures 10 and 11. The following comments apply:

a. Parallel alternate signal return conductors will be used in the experiment flat cables in lieu of the previously employed alternate shield conductors. This modification will reduce crosstalk on the timing and control lines.

b. The receiver mounting surface is not compatible with the gold finish and will thus be isolated from the thermal plate by an anodized aluminum shim less than 1/32 inch thick.

c. The PSE CSE will be isolated from the thermal plate in a manner similar to the receiver because its mounting surface is incompatible with gold.
SPLIT PHASE DATA
PWR, SIG & TM RTN

NOTE
EMI FILTER
* SOME TM CHANNELS MAY BE UNFILTERED

ALSEP TRANSMITTER - TELEDYNE

FIGURE 1
FIGURE 2

ALSEP TRANSMITTER – BxA
ALSEP ARRAY E RECEIVER

+12 V PWR
DC ACT. FIL

AUDIO OUTPUT

TM
TM & SEL CKTS

LOW FREQ CKTS

RF CKTS

DIPL ExER FILTER FEED

SIG., PWR. & TM RTN

CHASSIS RTN

FIGURE 3

EMI FILTER

8310P-W-23
ALSEP ARRAY E DIPLEXER SWITCH & FILTER

+12V
+12V RTN

MAG SW

DIPLEXER SWITCH

50 Ω

DIPLEXER FILTER

ANTENNA

RECEIVER

DIPLEXER SWITCH

FILTER

FIGURE 4
INPUT PWR
+12V, 5V
ANALOG
INTERFACES
DIGITAL
INTERFACES
PWR & SIG
RTN
(SAFETY)

ANALOG
CKTS

DIGITAL
CKTS

ALSEP ARRAY E COMMAND DECODER & DATA PROCESSOR 8310P-W-22

FIGURE 5
ALSEP ARRAY E PCU/PDU

RTG INPUT
+16V

PCU DC-DC CONVERTER

+29, +12
+5V

PDU RELAY DRIVERS
CKT BKRS & FUSES

+29V
+12V, 5V

EXPERIMENTS & TRANSMITTER

PWR RTN
(SAFETY)

PWR RTN
(SAFETY)

FIGURE 6
EXPERIMENT GROUNDING - TYPICAL
FOR LMS, LSG, HFE AND PSE

+29V PWR
+29V PWR
RTN
T, C, &
CMD
ANALOG
DIGITAL
SIGNAL
RTN
CHASSIS
RTN

DC-DC CONVERTER
EXPERIMENT
POWER

EXP PWR
RTN

EXPERIMENT
ELECTRONICS

PSE
SENSOR
SKEWS
CHASSIS
RTN
RTN

PSE CSE
ONLY

FIGURE 7
TYPICAL EXPERIMENT

NOTE: PWR & SIGNAL RTNS ARE PARALLEL CONDUCTORS IN FLAT CABLE

C/S THERMAL PLATE GROUND PLANE

ALSEP ARRAY E SYSTEM GROUNDING

FIGURE 10
ALSEP ARRAY E EXPERIMENT GROUNDING

| 8-50 FOOT FLAT CABLE |

LEAM
- PWR RTN
- SIGNAL & CHASSIS RTN

LMS
- PWR RTN
- SIGNAL RTN
- CHASSIS RTN

LSPE GEOPHONES
- 290 FEET SHIELDED TWISTED PAIR (DIFFERENTIAL SIGNAL)

LSG
- PWR RTN
- SIGNAL RTN
- CHASSIS RTN

HFE
- PWR RTN
- SIGNAL RTN
- CHASSIS RTN

NOTE: POWER & SIGNAL RTNS ARE PARALLEL CONDUCTORS IN FLAT CABLE

C/I THERMAL PLATE
- TB GROUND
- GROUND PLANE

PWR RTN
- SIGNAL RTN
- CHASSIS RTN

LSPE ELECTRONICS

PWR RTN
- SIGNAL RTN
- CHASSIS RTN

PSE ELECTRONICS (OPTIONAL)

FIGURE 11